


<b>Search Notes</b>  	<b>Application/Control No.</b>  10579418	<b>Applicant(s)/Patent Under Reexamination</b>  STEK ET AL.
	<b>Examiner</b>  Huynh, Phuong	<b>Art Unit</b>  2857

SEARCHED			
Class	Subclass	Date	Examiner
702	150	04/17/2007	PH
73	865.9	04/18/2007	PH
324	207.2; 207.25		

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Primary Examiner Blane Jackson (AU 2618): no search in 455	04/18/2007	PH
Consulted with Primary Examiner Thomas Noland : 73/865.9; 324/207.2, 207.25	04/18/2007	PH
702/150; 73/865.9; 324/207.2, 207.25 with text	04/18/2007	PH
Assignment data (eDan)	04/18/2007	PH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner